Mini Tower Items for Further Discussion PSR AI#1

- 1. TOT difference between the High Side and Low Side for each MCM Test method, Hardware problem etc
- 2. Better understanding of the detection efficiency performance of each of the layers does the location of the layer with respect to MT configuration have an impact
- 3. Noise Occupancy variation of the layer X2 between the 1200 and 1500 strips
- 4. Amplifier gain variations of all the MCMs reason for this variation could be bias voltage variation between chips due to distribution on the board etc.
- 5. Verification that the CAL TEM and PSA have the same interface with the Tracker prior to integrating the MT with the CAL, TEM and PSA.
- 6. If possible the performance of the MT be verified as a stand-alone unit with the CAL TEM PRIOR to integration with the CAL.
- 7. There should be effort to develop more quantitative GO/NOGO criteria for the acceptance of the Tracker some key parameters should go into the specification.

Nanda 19 August,2003 Pisa, Italy